## Search Notes



Class

Application/Control I	۱o.

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Applicant(s)/Patent Under Reexamination

CHATTERJEE ET AL.

Date

Examiner

Examiner
Lin, Shew-Fen

Art Unit 2166

	SEARCHED	

Subclass

SEARCH NOTES		
Search Notes	Date	Examiner
East	12/1/2007	SFL
Consult Khanh Pham (Primary Examiner 2166)	12/3/2007	SFL
East text search	7/16/08-7/17/08	SFL

	RCH		
Class	Subclass	Date	Examiner

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